

# Search Notes



Application No.

10/667,012

Examiner

Edward Wojciechowicz

Applicant(s)

CHEN ET AL.

Art Unit

2815

## SEARCHED

Class	Subclass	Date	Examiner
257	408, 360	11-10-04	EA
438	199, 200		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR